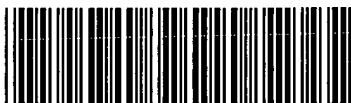


**Search Notes**

Application/Control No.

10/670,571

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under  
Reexamination

OHNO ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
336	83, 175, 200, 206- 208, 220- 223	10/15/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR